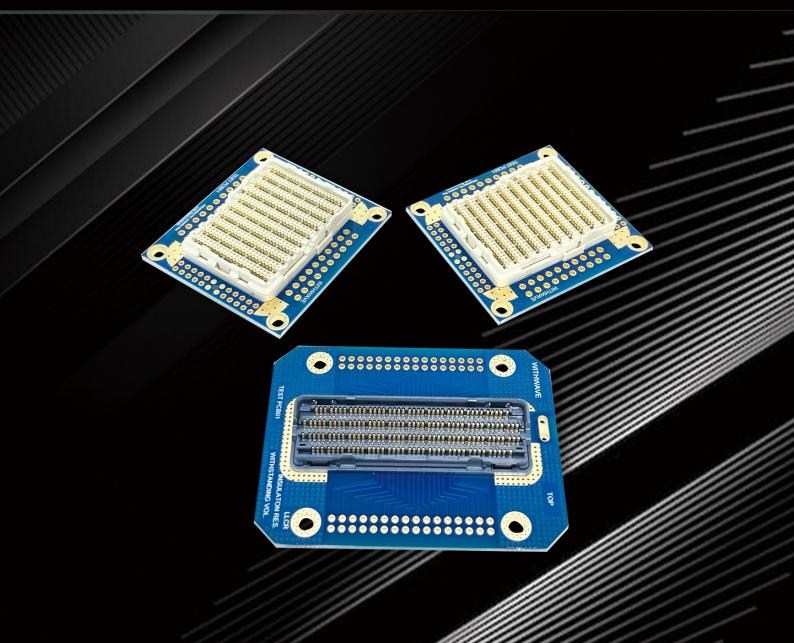


HSB Series

High Speed Board to Board Connector



Withwave's high-speed connectors are hermaphroditic and based on differential pair 100 Ohm (or 92 Ohm) nominal impedance, providing excellent high-bandwidth applications *56 Gbps NRZ*, *112 Gbps PAM-4* with high pin count and high pitch depending on the product type.

These products are designed based on Surface Mount BGA Pin design technology.



Benefits

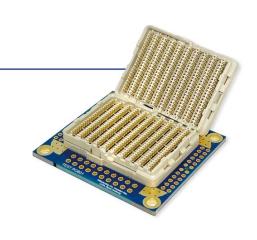
- Minimizes impedance discontinuities
- Excellent insertion and return loss performance
- Low crosstalk noise and resonances
- Biggest forced-offset (Rigid alignment) tolerance

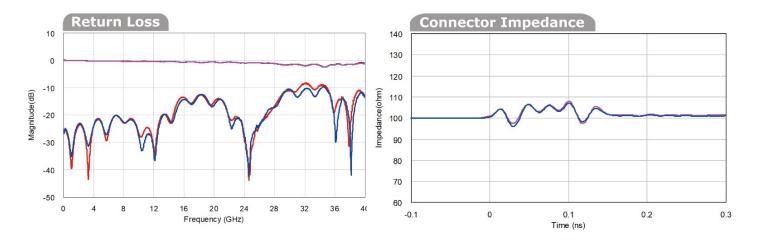
Application

- Telecommunication and Data Embedded
- Data Servers and Storage
- Industrial Controls and Equipment
- Test & Measurement Electronics

High speed connector 1.0 mm Pitch Systems

- Higher bandwidth applications 56 Gbps NRZ, 112 Gbps PAM-4
- Stack heights from 8.4mm
- Connector Size: 35.6mm x 26.6mm
- High pin counts: 418 total contacts (95 differential pairs)
- Pitch 1.0mm x 1.6mm
- Differential pair 100ohm nominal impedance
- Surface Mount BGA Pin Design





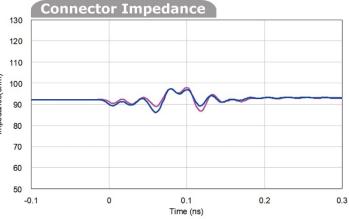
High speed connector 0.9 mm Pitch Systems

- Higher bandwidth applications 56 Gbps NRZ, 112 Gbps PAM-4
- Stack heights from 5.0mm
- Pitch 0.9mm x 1.5mm
- · Differential pair 92ohm nominal impedance
- · Surface Mount BGA Pin Design

| Connector Size | High pin counts | Part No. |
|----------------|-----------------------------|--------------------|
| 48.0 x 15.6 | 292 (66 Differential pairs) | HSB01_M292S01H050A |
| 32.0 x 12.6 | 120 (25 Differential pairs) | HSB02_M120S01H050A |







Specifications

ELECTRICAL PERFORMANCE

| Test items | International Standard | Test Condition |
|--------------------------------------|--------------------------------|--|
| Contact Resistance (Low Level) | EIA-364-23 | 20 mV Max., 100 mA <10mΩ change from initial reading after environmental exposure> |
| Insulation Resistance | EIA-364-21 | 500Vrms (DC), 60Sec., 1000Mohm |
| Withstanding Voltage (Dielectric) | EIA-364-20 | 500Vrms (AC), 60Sec. |
| Temperature Rise | EIA-364-70 Test Condition 3 | 0.5A, Temperature rise : 30 ℃ |

MECHANICAL PERFORMANCE

| Test items | International Standard | Test Condition |
|------------------|---------------------------|--|
| Durability | EIA-364-09 | 200 Cycles |
| Mating Un-mating | EIA-364-13 | Mating Force 0.45N max. per contact Un-mating Force 0.1N min. per contact |

ENVIRONMENTAL

| Test items | International Standard | Test Condition |
|------------------|--|---|
| Vibration | EIA-364-28 Test Condition III | 15G, 15 – 2000 - 15Hz, 15minutes. (X, Y, Z) LLCR: <10mΩ change |
| Mechanical Shock | EIA-364-27 Test Condition A | 490m/s^2 (50G), Normal Duration of 11ms (X, Y, Z) LLCR: <10mΩ change |
| Thermal Shock | EIA-364-32 Method A Test condition I | -55°C ~ +85°C, 1/2 Hours, 25cycles LLCR: <10mΩ change |
| Temperature life | EIA-364-17 | 105 ± 2°C, 250Hours LLCR: <10mΩ change |

| MATERIAL | |
|------------|---|
| Housing | High-Temperature LCP, UL94V-01 |
| Contacts | High performance Copper Alloy |
| Plating(s) | Contact Area Gold(Au) Nickel(Ni) Overall |